



SGM25733Q

Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

GENERAL DESCRIPTION

The SGM25733Q, an ideal diode controller used as an ideal diode rectifier with external NMOS, offers low-loss reverse polarity protection, which has a mere 20mV forward voltage drop. Its 3.2V to 65V wide supply input range facilitates control over various DC bus voltages commonly found in automotive battery systems like 12V, 24V, and 48V. The device supports input voltage downs to 3.2V, making it well-suited for automotive systems with stringent cold crank conditions. It also protects connected loads against reverse supply voltages as low as -65V.

Controlling the GATE of MOSFET, the device regulates the 20mV forward voltage drop. The control architecture ensures the external MOSFET turns off in the event of reverse current, effectively preventing any steady-state reverse current flow. With a rapid reverse current blocking response time of less than 0.88 μ s, the device is well-suited for applications requiring output voltage hold-up during ISO7637 pulse tests, as well as during input micro-short and power fail scenarios.

This controller incorporates a charge pump gate driver for an external NMOS. Its high voltage rating simplifies system designs for automotive EMC transient interference standard ISO7637. When the enable pin is held low, the controller remains disabled and consumes only about 1.2 μ A of supply current.

The device is AEC-Q100 qualified (Automotive Electronics Council (AEC) standard Q100 Grade 1) and it is suitable for automotive applications.

The SGM25733Q is available in a Green SOT-23-6 package.

FEATURES

- AEC-Q100 Qualified for Automotive Applications
Device Temperature Grade 1
 $T_A = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$
- Functional Safety-Capable
- Documentation Available for Assisting in Functional Safety System Design
- 3.2V to 65V Input Range (3.9V Start-Up)
- -65V Reverse Voltage Rating
- Charge Pump for External NMOS
- Regulation of 20mV Forward Voltage Drop from ANODE to CATHODE
- Enable Pin Feature
- 1.2 μ A Shutdown Current (EN = Low)
- 98 μ A Operating Quiescent Current (EN = High)
- 1.8A Peak Gate Turn-Off Current
- Quick Response Time to Reverse Current Blocking: < 0.88 μ s
- Compliance with Automotive ISO7637 Transient Requirements with Appropriate TVS Diode
- Available in a Green SOT-23-6 Package

APPLICATIONS

Automotive Infotainment Systems: Digital Cluster and Head Unit

Active ORing for Redundant Power Systems

Automotive ADAS Systems: Camera Integration

Enterprise Power Supplies

Industrial Factory Automation: PLC Integration

TYPICAL APPLICATION SCHEMATIC

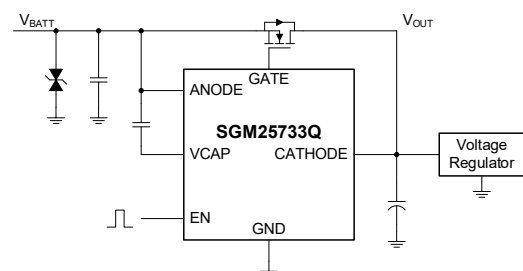


Figure 1. Application Schematic

SGM25733Q

Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

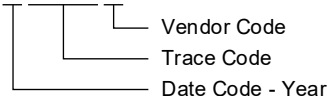
PACKAGE/ORDERING INFORMATION

| MODEL | PACKAGE DESCRIPTION | SPECIFIED TEMPERATURE RANGE | ORDERING NUMBER | PACKAGE MARKING | PACKING OPTION |
|-----------|---------------------|-----------------------------|-----------------|-----------------|---------------------|
| SGM25733Q | SOT-23-6 | -40°C to +125°C | SGM25733QN6G/TR | 175 XXXXX | Tape and Reel, 3000 |

MARKING INFORMATION

NOTE: XXXXX = Date Code, Trace Code and Vendor Code.

XXXXX



Green (RoHS & HSF): SG Micro Corp defines "Green" to mean Pb-Free (RoHS compatible) and free of halogen substances. If you have additional comments or questions, please contact your SGMICRO representative directly.

ABSOLUTE MAXIMUM RATINGS

Input Pins

| | |
|--|----------------------------------|
| ANODE to GND | -65V to 65V |
| EN to GND, ($V_{ANODE} > 0V$) | -0.3V to 65V |
| EN to GND, ($V_{ANODE} \leq 0V$) | V_{ANODE} to 65V + V_{ANODE} |

Output Pins

| | |
|--|----------------------------------|
| GATE to ANODE | -0.3V to 15V |
| VCAP to ANODE | -0.3V to 15V |
| CATHODE to GND, ($V_{ANODE} > 0V$) | -0.3V to 75V |
| CATHODE to GND, ($V_{ANODE} \leq 0V$) .. | V_{ANODE} to 75V + V_{ANODE} |

Output to Input Pins

| | |
|------------------------|------------|
| CATHODE to ANODE | -5V to 75V |
|------------------------|------------|

Package Thermal Resistance

| | |
|-------------------------------|-----------|
| SOT-23-6, θ_{JA} | 145.4°C/W |
| SOT-23-6, θ_{JB} | 39.7°C/W |
| SOT-23-6, θ_{JC} | 89.1°C/W |

Junction Temperature +150°C

Storage Temperature Range -65°C to +150°C

Lead Temperature (Soldering, 10s) +260°C

ESD Susceptibility ^{(1) (2)}

HBM (Connect EN Pin to Anode Pin) ±2000V

HBM (All Pins Except EN) ⁽³⁾ ±2000V

CDM ±1000V

NOTES:

1. For human body model (HBM), all pins comply with AEC-Q100-002 specification.
2. For charged device model (CDM), all pins comply with AEC-Q100-011 specification.
3. The human body model is a 100pF capacitor discharged through a 1.5kΩ resistor into each pin. 2kV rating for all pins except EN, which is rated for 1.5kV.

RECOMMENDED OPERATING CONDITIONS

Input Pins

| | |
|----------------------|-------------|
| ANODE to GND | -60V to 60V |
| CATHODE to GND | 60V |
| EN to GND | -60V to 60V |

Input to Output Pins

| | |
|------------------------|--------|
| ANODE to CATHODE | ≥ -70V |
|------------------------|--------|

External Capacitance

| | |
|------------------------------|---------|
| ANODE | ≥ 22nF |
| CATHODE, VCAP to ANODE | ≥ 0.1μF |

External MOSFET Max V_{GS} Rating

| | |
|---------------------|-------|
| GATE to ANODE | ≥ 15V |
|---------------------|-------|

Operating Ambient Temperature Range -40°C to +125°C

OVERSTRESS CAUTION

Stresses beyond those listed in Absolute Maximum Ratings may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect reliability. Functional operation of the device at any conditions beyond those indicated in the Recommended Operating Conditions section is not implied.

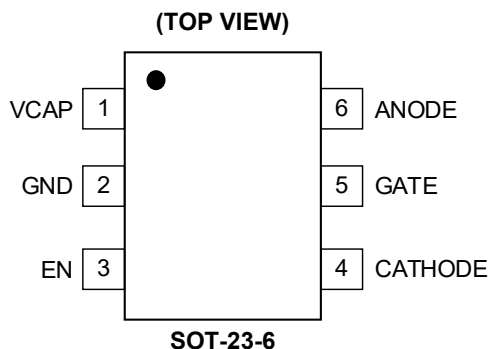
ESD SENSITIVITY CAUTION

This integrated circuit can be damaged if ESD protections are not considered carefully. SGMICRO recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage. ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because even small parametric changes could cause the device not to meet the published specifications.

DISCLAIMER

SG Micro Corp reserves the right to make any change in circuit design, or specifications without prior notice.

PIN CONFIGURATION



PIN DESCRIPTION

| PIN | NAME | TYPE ⁽¹⁾ | FUNCTION |
|-----|---------|---------------------|---|
| 1 | VCAP | O | Charge Pump Output. This pin is connected to external charge pump capacitor. |
| 2 | GND | G | Ground. |
| 3 | EN | I | Enable. This pin is connected to ANODE during always ON operation. |
| 4 | CATHODE | I | Cathode of the Diode. This pin is connected to the drain of the external MOSFET. |
| 5 | GATE | O | Gate Drive Output. This pin is connected to the gate of the external MOSFET. |
| 6 | ANODE | I | Anode of the Diode and Input Power. This pin is connected to the source of the external MOSFET. |

NOTE: 1. I = input, O = output, G = ground.

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ELECTRICAL CHARACTERISTICS

(T_J = -40°C to +125°C, all typical values are measured at T_J = +25°C, V_{ANODE} = 12V, C_{VCAP} = 0.1μF and V_{EN} = 3.3V, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|----------------------------|--|------|------|------|-------|
| V_{ANODE} Supply Voltage | | | | | | |
| Operating Input Voltage | V _{ANODE} | | 4 | 12 | 60 | V |
| VANODE POR Rising Threshold | V _{ANODE_POR} | | | | 3.9 | V |
| VANODE POR Falling Threshold | | | 2.46 | 2.78 | 3.08 | V |
| VANODE POR Hysteresis | V _{ANODE_POR_Hys} | | 0.73 | | 1.03 | V |
| Shutdown Supply Current | I _{SD} | V _{EN} = 0V | | 1.2 | 3.0 | μA |
| Operating Quiescent Current | I _Q | | | 98 | 135 | μA |
| Enable Input | | | | | | |
| Enable Input Low Threshold | V _{EN_IL} | | 0.90 | 1.20 | 1.52 | V |
| Enable Input High Threshold | V _{EN_IH} | | 1.79 | 2.11 | 2.45 | V |
| Enable Hysteresis | V _{EN_Hys} | | 0.59 | 0.91 | 1.20 | V |
| Enable Sink Current | I _{EN} | V _{EN} = 12V | | 1.9 | 4.0 | μA |
| V_{ANODE} to V_{CATHODE} | | | | | | |
| Regulated Forward V _{AK} Threshold | V _{AK_REG} | | 11 | 20 | 29 | mV |
| V _{AK} Threshold for Full Conduction Mode | V _{AK} | | 31 | 46 | 61 | mV |
| V _{AK} Threshold for Reverse Current Blocking | V _{AK_REV} | | -22 | -11 | -1 | mV |
| Regulation Error AMP Transconductance ⁽¹⁾ | G _m | | 1200 | 1800 | 3100 | μA/V |
| Gate Drive | | | | | | |
| Peak Source Current | I _{GATE} | V _{ANODE} - V _{CATHODE} = 100mV, V _{GATE} - V _{ANODE} = 5V | 5 | 10.2 | | mA |
| Peak Sink Current | | V _{ANODE} - V _{CATHODE} = -100mV, V _{GATE} - V _{ANODE} = 5V | | 1800 | | mA |
| Regulation Max Sink Current | | V _{ANODE} - V _{CATHODE} = 0V, V _{GATE} - V _{ANODE} = 5V | 6 | 24 | | μA |
| Discharge Switch R _{DS(on)} | R _{DS(on)} | V _{ANODE} - V _{CATHODE} = -100mV, V _{GATE} - V _{ANODE} = 100mV | 0.4 | | 2.3 | Ω |

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ELECTRICAL CHARACTERISTICS (continued)

($T_J = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, all typical values are measured at $T_J = +25^{\circ}\text{C}$, $V_{\text{ANODE}} = 12\text{V}$, $C_{\text{VCAP}} = 0.1\mu\text{F}$ and $V_{\text{EN}} = 3.3\text{V}$, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|---|--|--|------|-------|------|-------|
| Charge Pump | | | | | | |
| Charge Pump Source Current (Charge Pump On) | I _{VCAP} | V _{VCAP} - V _{ANODE} = 7V | 200 | 300 | 400 | μA |
| Charge Pump Sink Current (Charge Pump Off) | | V _{VCAP} - V _{ANODE} = 13V | | 4 | 10 | μA |
| Charge Pump Voltage at V _{ANODE} = 3.2V | V _{VCAP} - V _{ANODE} | I _{VCAP} ≤ 10μA | 7.6 | | | V |
| Charge Pump Turn-On Voltage | | | 9.1 | 10.5 | 12.0 | V |
| Charge Pump Turn-Off Voltage | | | 10.0 | 11.6 | 13.0 | V |
| Charge Pump Enable Comparator Hysteresis | | | 0.6 | 1.0 | 1.4 | V |
| V _{VCAP} - V _{ANODE} UV Release | V _{VCAP_UVLO} | V _{ANODE} - V _{CATHODE} = 100mV, rising edge | 5.50 | 6.28 | 7.10 | V |
| V _{VCAP} - V _{ANODE} UV Threshold | | V _{ANODE} - V _{CATHODE} = 100mV, falling edge | 4.60 | 5.36 | 6.10 | V |
| CATHODE | | | | | | |
| CATHODE Sink Current | I _{CATHODE} | V _{ANODE} = 12V, V _{ANODE} - V _{CATHODE} = -100mV | | 1.9 | 3.0 | μA |
| | | V _{ANODE} - V _{CATHODE} = -100mV | | 1.9 | 3.0 | μA |
| | | V _{ANODE} = -12V, V _{CATHODE} = 12V | | -0.01 | 0.50 | μA |

NOTE:

1. Parameter assured by design and characterization.

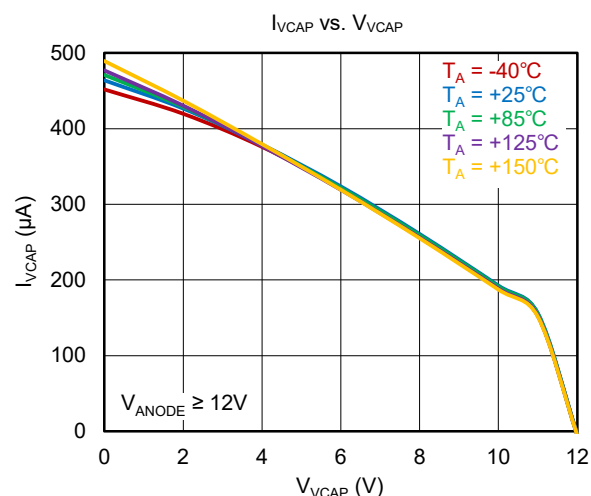
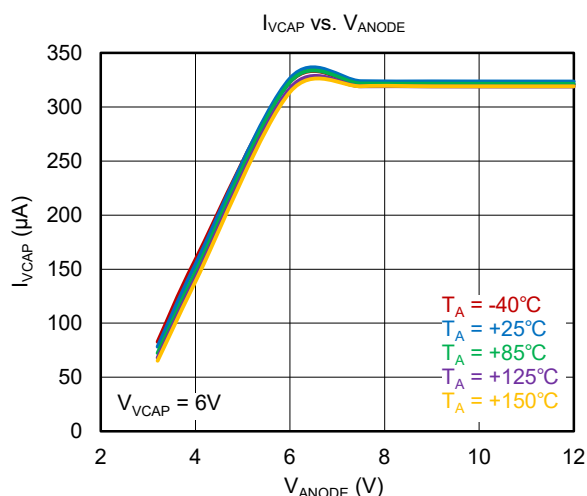
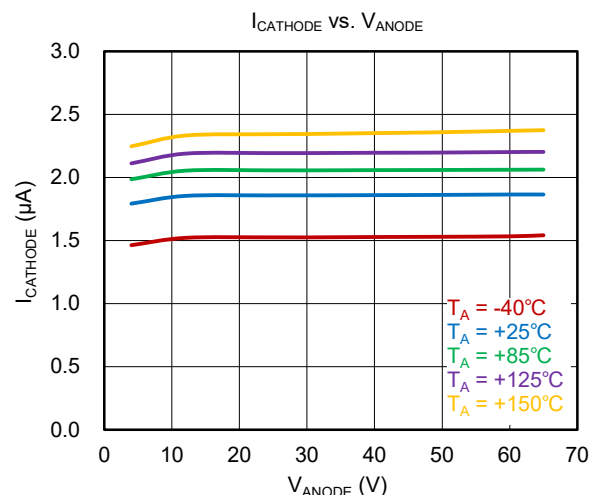
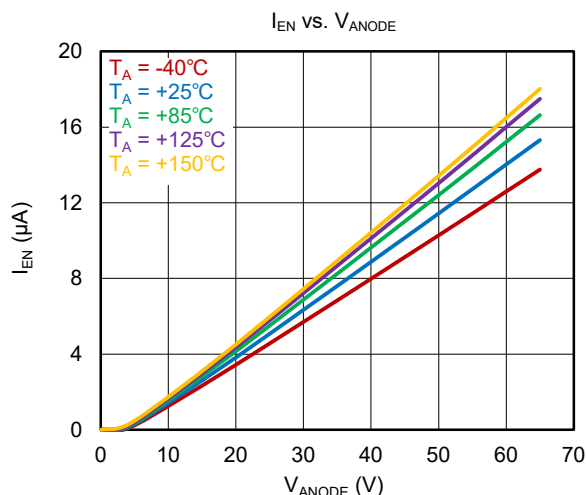
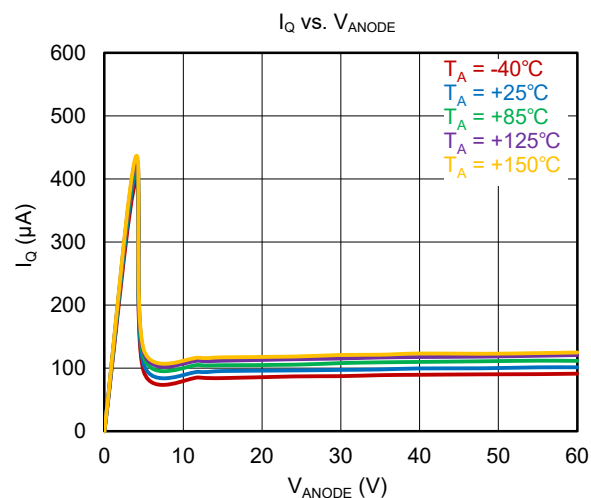
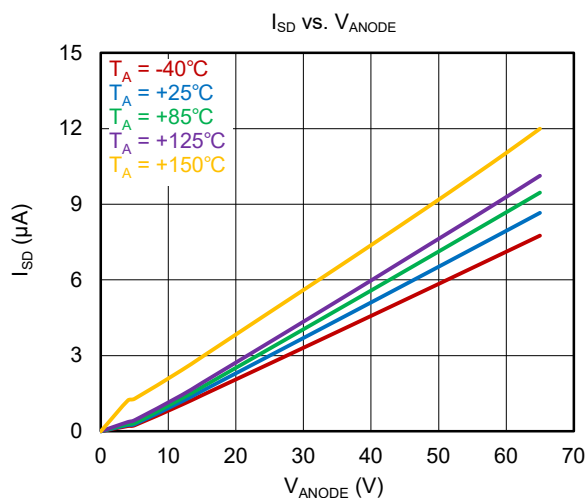
SWITCHING CHARACTERISTICS

($T_J = -40^{\circ}\text{C}$ to $+125^{\circ}\text{C}$, all typical values are measured at $T_J = +25^{\circ}\text{C}$, $V_{\text{ANODE}} = 12\text{V}$, $C_{\text{VCAP}} = 0.1\mu\text{F}$ and $V_{\text{EN}} = 3.3\text{V}$, unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|--------------------------------|---|-----|------|------|---------------|
| Enable to Gate Turn-On Delay | EN_{TDLY} | $V_{\text{VCAP}} > V_{\text{VCAP_UVLO_R}}$ | | 83 | 121 | μs |
| Reverse Voltage Detection to Gate Turn-Off Delay | $t_{\text{Reverse_Delay}}$ | $V_{\text{ANODE}} - V_{\text{CATHODE}} = 100\text{mV}$ to -100mV | | 0.44 | 0.88 | μs |
| Forward Voltage Detection to Gate Turn-On Delay | $t_{\text{Forward_Recovery}}$ | $V_{\text{ANODE}} - V_{\text{CATHODE}} = -100\text{mV}$ to 700mV | | 1.91 | 3.60 | μs |

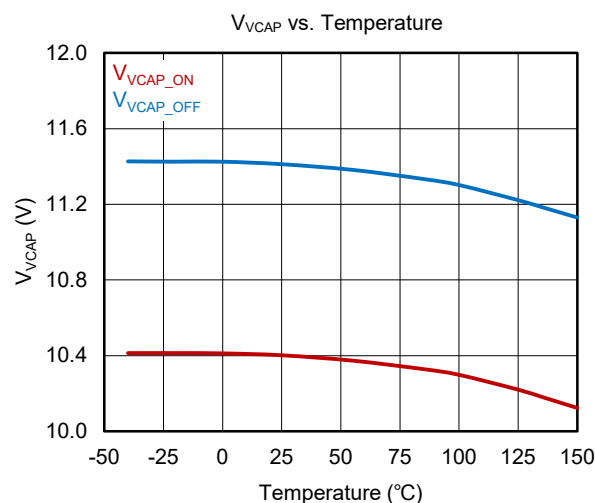
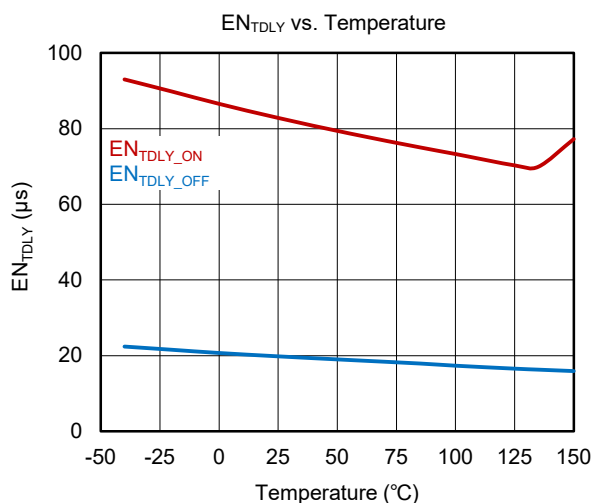
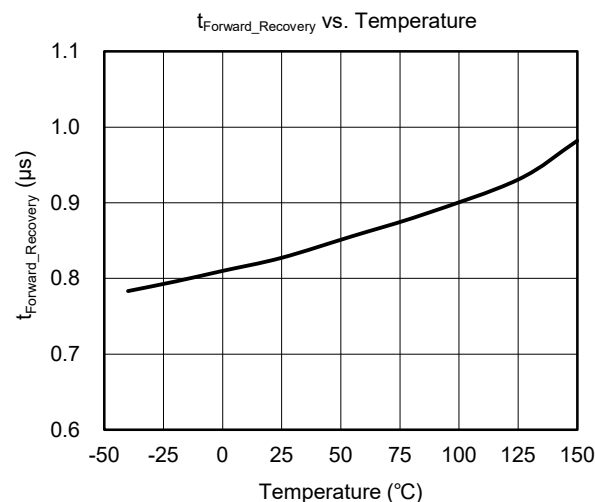
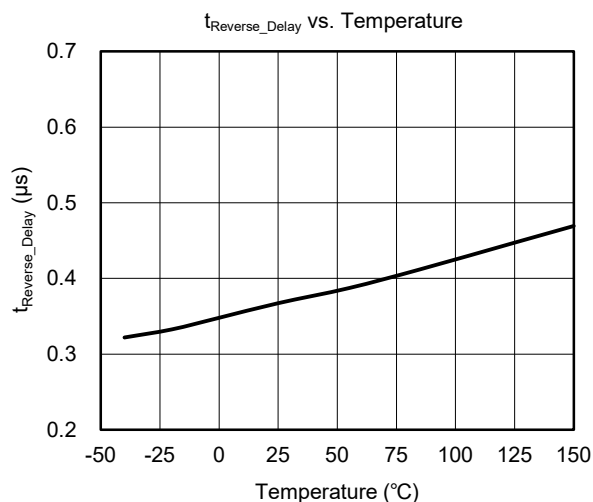
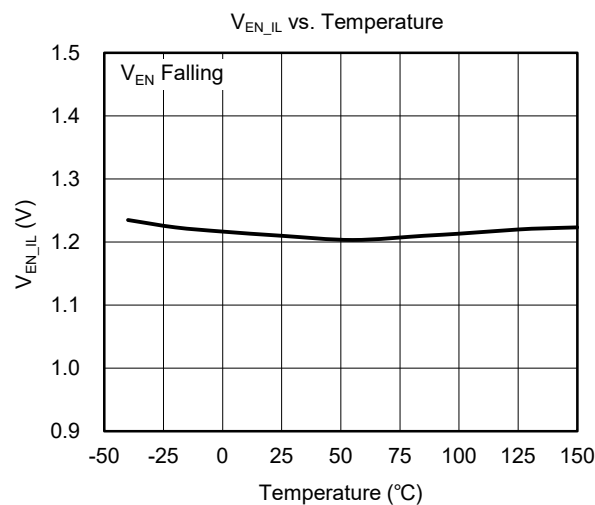
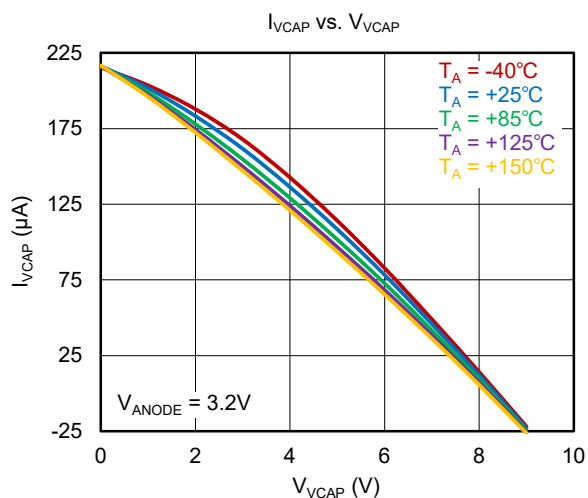
SGM25733Q Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

TYPICAL PERFORMANCE CHARACTERISTICS



SGM25733Q Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

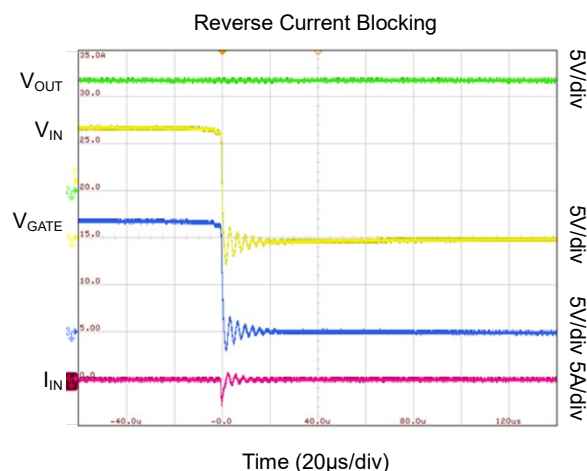
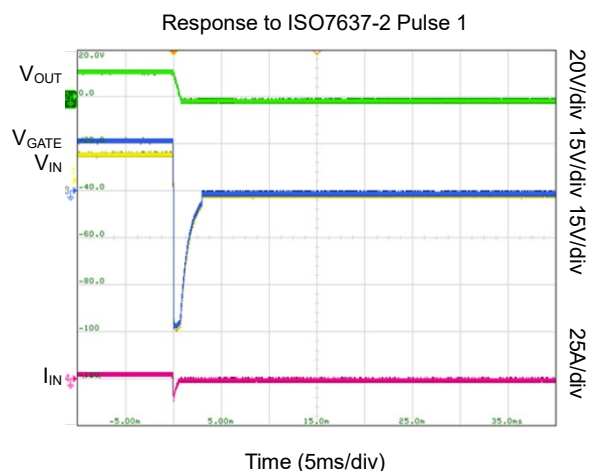
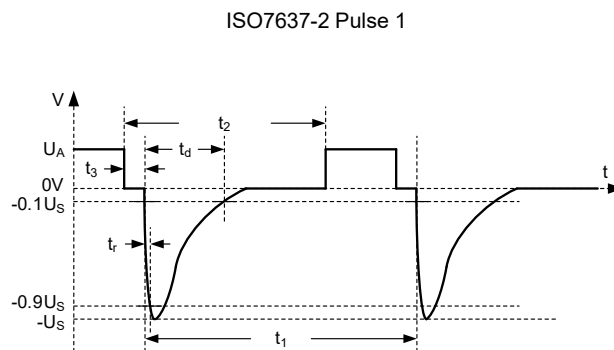
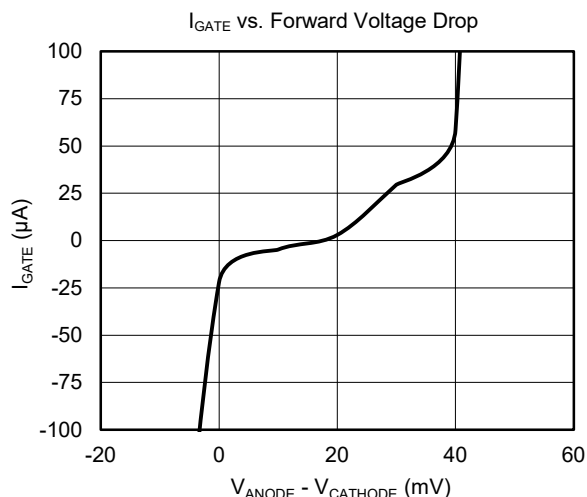
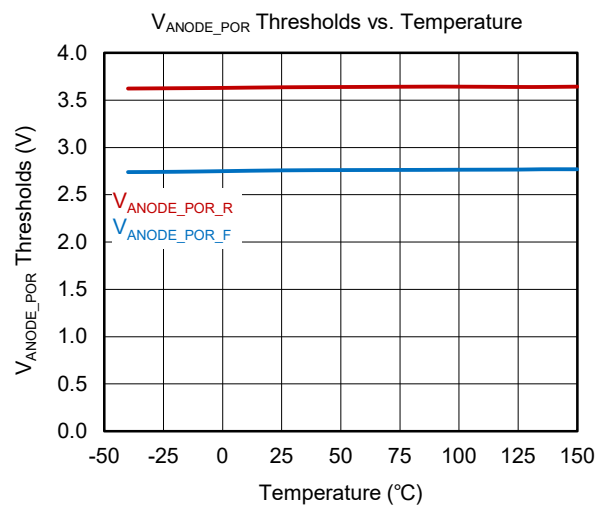
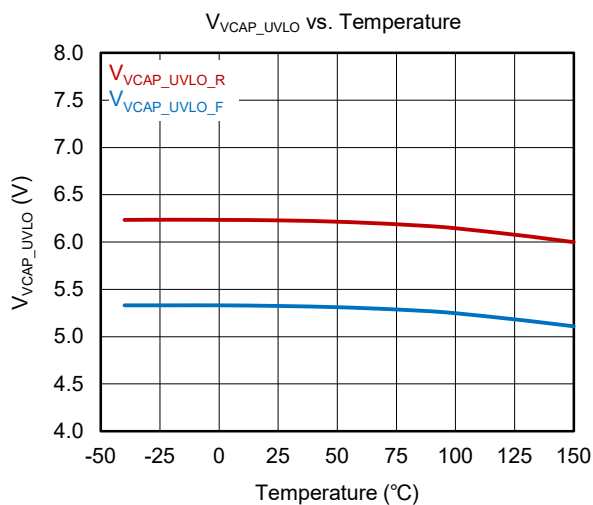
TYPICAL PERFORMANCE CHARACTERISTICS (continued)



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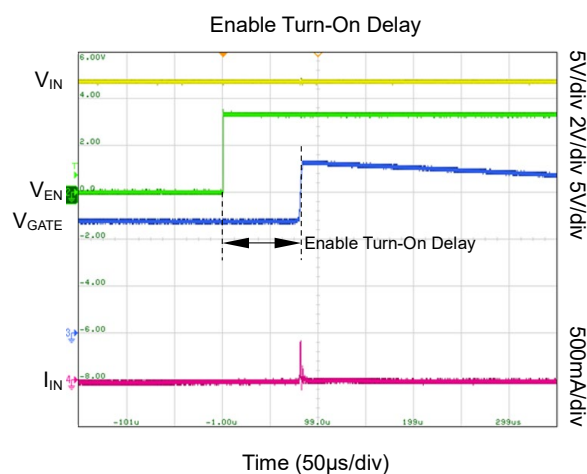
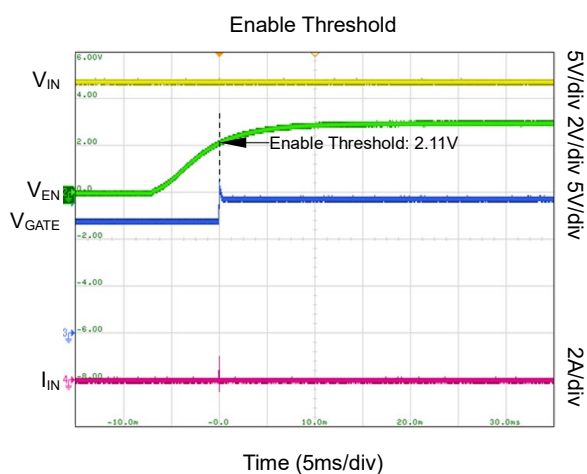
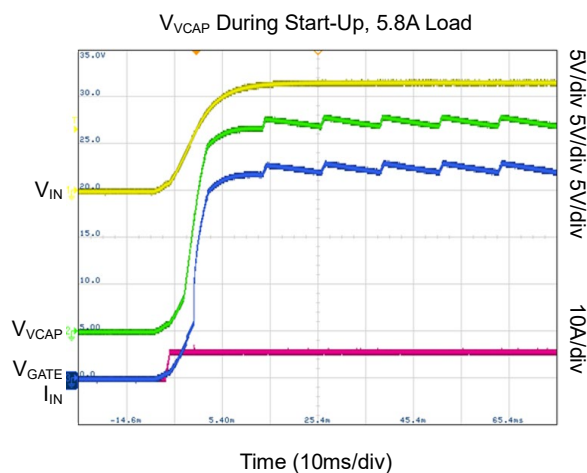
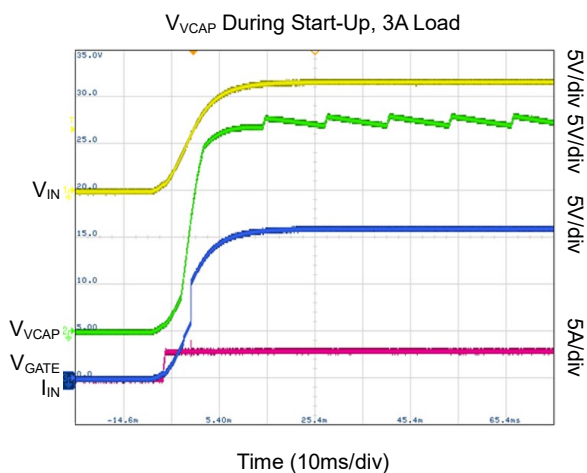
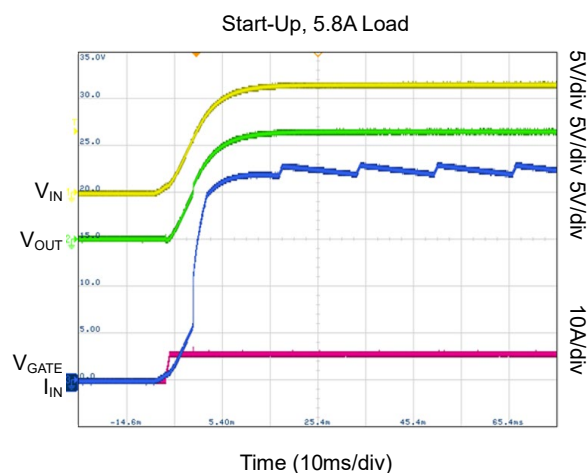
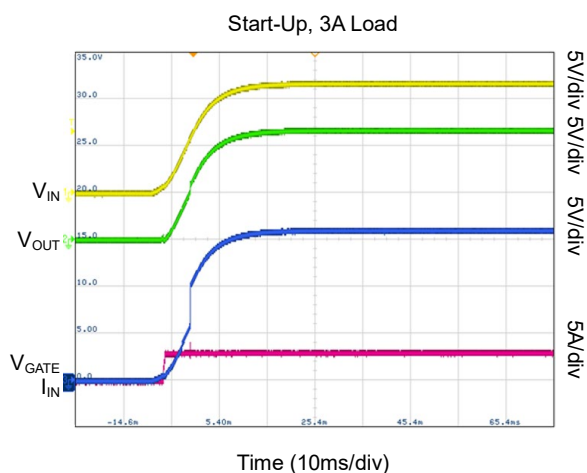
TYPICAL PERFORMANCE CHARACTERISTICS (continued)



SGM25733Q Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

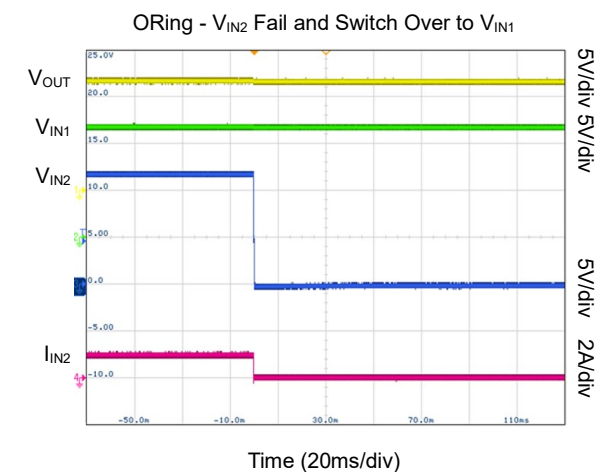
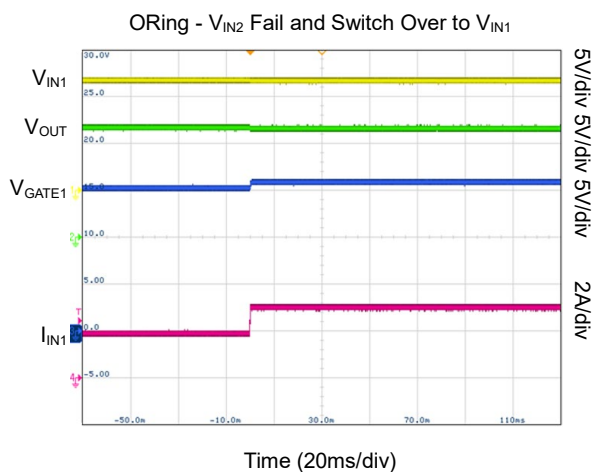
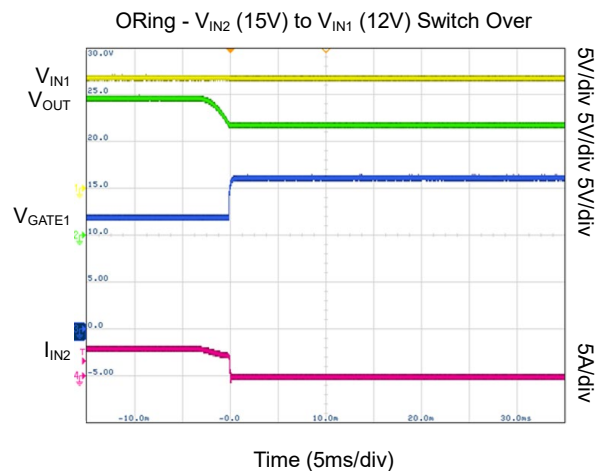
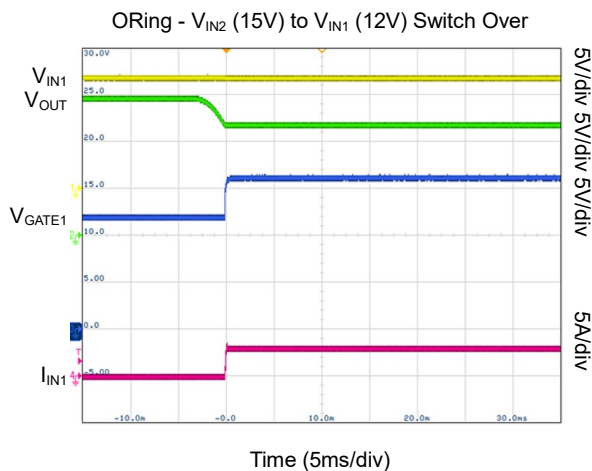
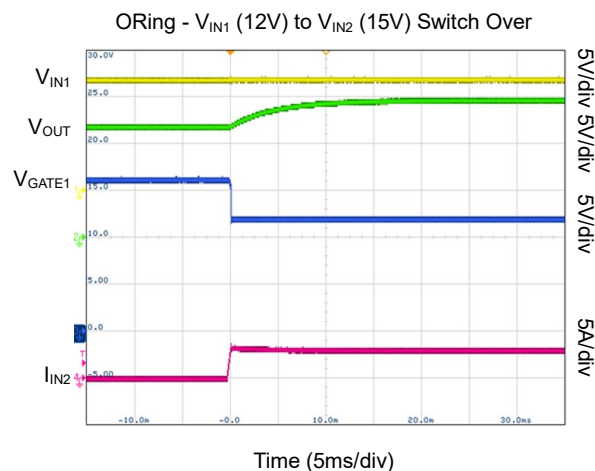
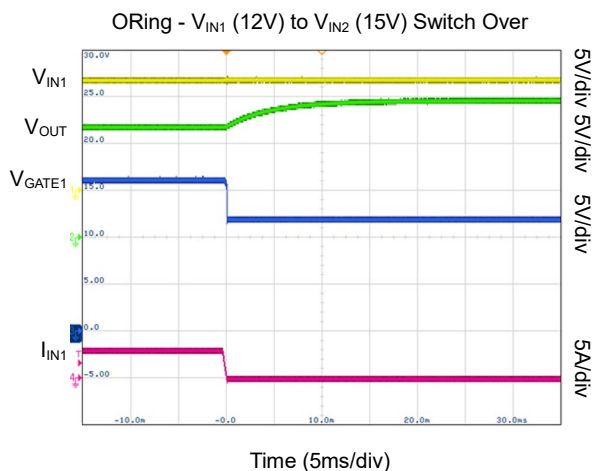
$T_A = +25^\circ\text{C}$, $V_{IN} = 12\text{V}$, $C_{VCAP} = 0.1\mu\text{F}$ and $C_{OUT} = 2.2\mu\text{F}$, unless otherwise noted.



SGM25733Q Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

TYPICAL PERFORMANCE CHARACTERISTICS (continued)

$T_A = +25^\circ\text{C}$, $C_{V\text{CAP}} = 0.1\mu\text{F}$, $C_{\text{OUT}} = 470\mu\text{F}$, unless otherwise noted.



TIMING DIAGRAMS

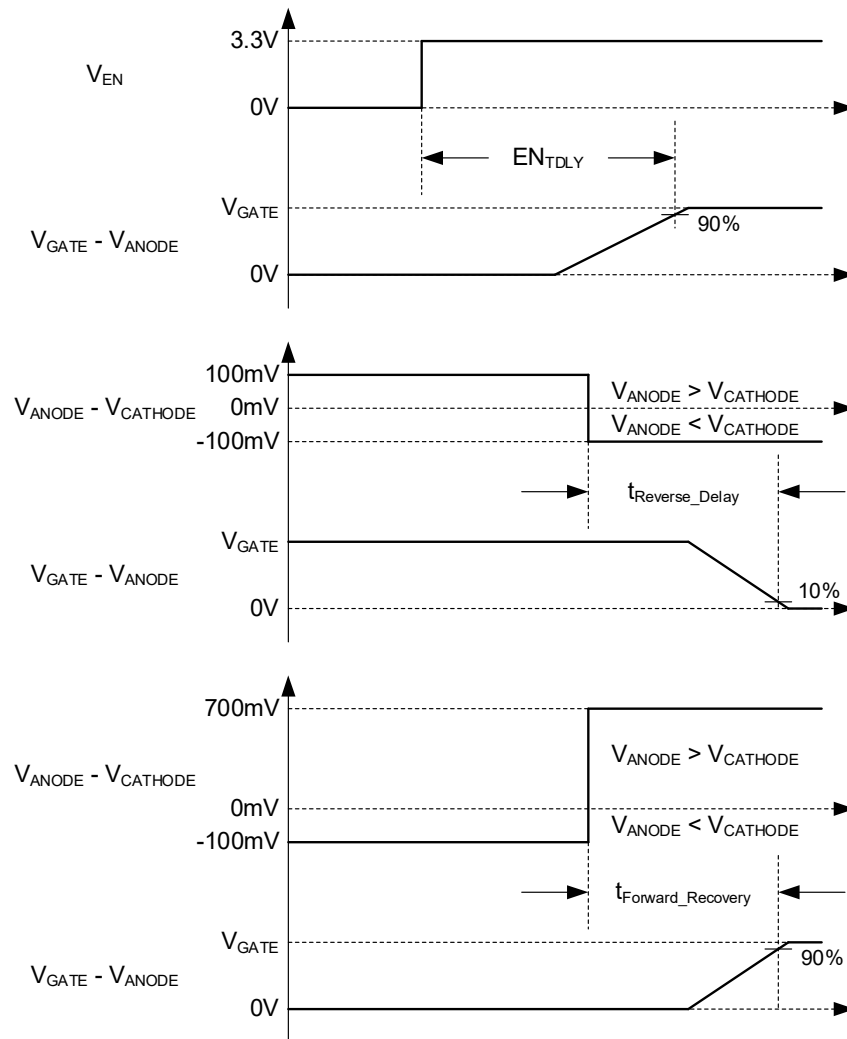


Figure 2. Timing Diagrams

FUNCTIONAL BLOCK DIAGRAM

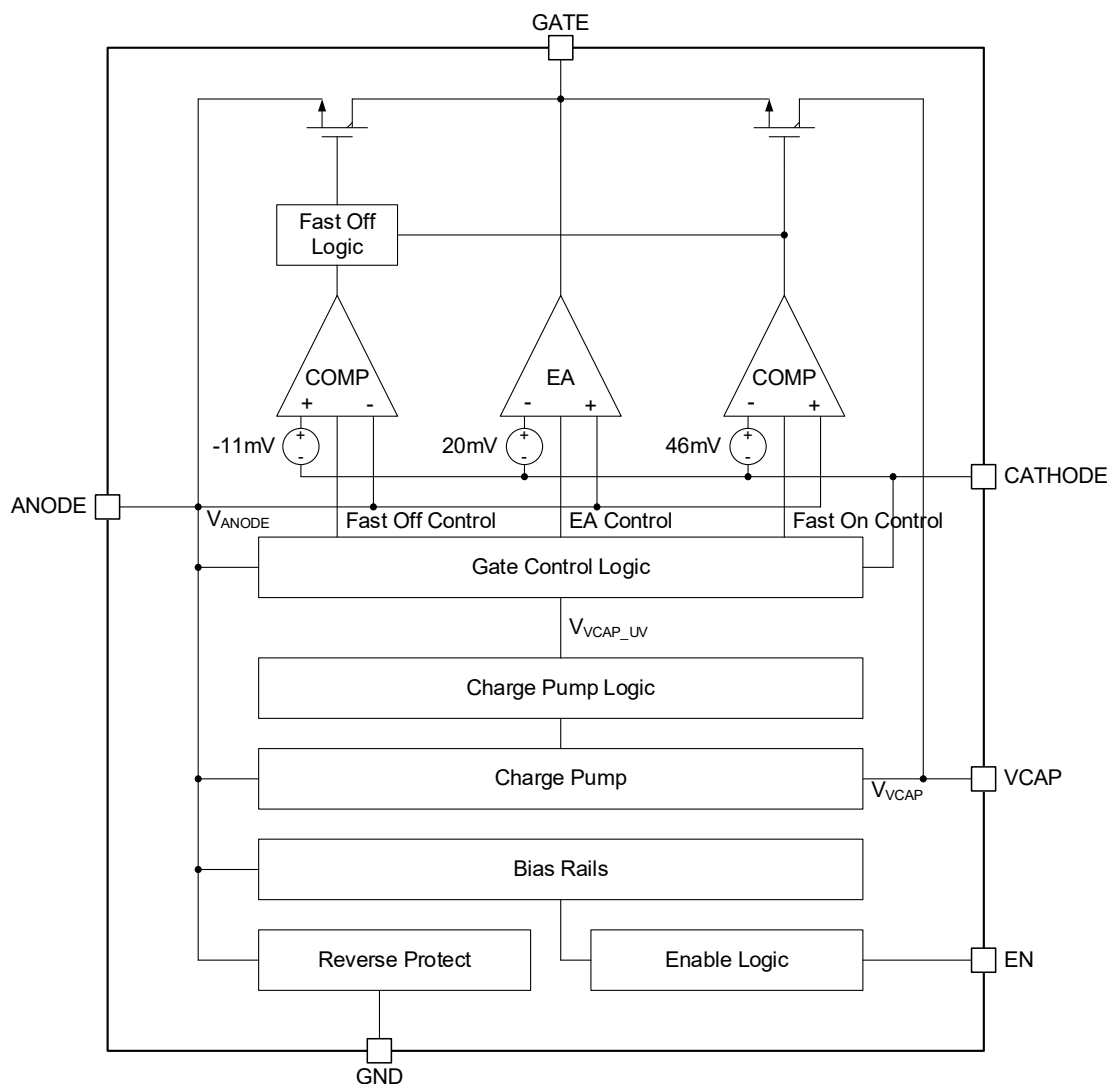


Figure 3. Block Diagram

DETAILED DESCRIPTION

The SGM25733Q ideal diode controller integrates all the essential functions for building a fast, efficient reverse polarity protection circuit or implementing an ORing configuration, all while requiring minimal external components. At the same time, it minimizes the amount of external components. This user-friendly ideal diode controller is combined with an NMOS situated externally. The user-friendly ideal diode controller, combined with an external NMOS, replaces PMOSs or Schottky diodes for reverse polarity protection. Its internal charge pump drives the MOSFET with a max 15V gate voltage.

The device constantly measures the voltage across the MOSFET via the ANODE and CATHODE pins, dynamically adjusting the GATE-to-ANODE voltage to maintain a forward voltage drop of 20mV. This closed-loop control mechanism allows for smooth MOSFET turn-off during reverse current conditions and guarantees zero steady-state reverse current. When the voltage difference between the ANODE and CATHODE pins is lower than -11mV, it triggers the detection of a rapid reverse current event. Subsequently, an internal connection is made between the GATE pin and the ANODE pin, effectively deactivating the external NMOS. And the body diode takes over to block all reverse current flows. There is also an enable pin called EN. By using this pin, the SGM25733Q can enter shutdown mode, which disables the NMOS and reduces the quiescent current to the minimum.

Input Voltage

The ANODE pin supplies power to the internal circuitry of the SGM25733Q. Generally, it consumes 98μA when it is enabled and 1.2μA when disabled. When the voltage of the ANODE pin exceeds the POR Rising threshold, the SGM25733Q will operate either in shutdown mode or conduction mode, depending on the voltage of the EN pin. The designed voltage range from the ANODE to GND is from 65V to -65V. This enables the SGM25733Q to endure negative voltage transients.

Charge Pump

The external NMOS is driven by the voltage produced by the charge pump. An external charge-pump capacitor is positioned between the VCAP and ANODE pins. This capacitor supplies the energy required to activate the external MOSFET. For the charge pump to deliver current to the external capacitor, the EN pin voltage must exceed the defined input high threshold, V_{EN_IH} . Once enabled, the charge pump typically provides a charging current of 300μA. When the EN pin is set to a low level, the charge pump remains inoperative. In order to guarantee the external MOSFET can be driven to a voltage higher than its specified threshold, the voltage between VCAP pin and ANODE pin must exceed the under-voltage lockout threshold, which is typically 6.28V. This condition must be met before enabling the internal gate driver. Calculate the initial gate driver enable delay using Equation 1. Here, C_{VCAP} represents the charge-pump capacitance connected between the ANODE pin and VCAP pin, and $V_{VCAP_UVLO_R} = 6.28V$ (TYP).

$$t_{DRV_EN} = 75\mu s + C_{VCAP} \times \frac{V_{VCAP_UVLO_R}}{300\mu A} \quad (1)$$

To eliminate gate drive chatter, approximately 900mV of hysteresis is applied to the VCAP under-voltage lockout threshold. The charge pump continues operating until the VCAP-to-ANODE voltage rises to 11.6V (TYP). Once this voltage level is reached, the charge pump is switched off. This action results in a reduction of the current consumption on the ANODE pin. The charge pump remains in the disabled state until the voltage from VCAP to ANODE drops below 10.5V typically. Once this voltage condition is met, the charge pump is activated. As illustrated in Figure 4, the voltage between VCAP and ANODE cycles through charging and discharging processes within the range of 10.5V to 11.6V. This on-off operation of the charge pump serves to reduce the quiescent operating current of the SGM25733Q. When disabled, the charge pump typically sinks a current of 4μA.

DETAILED DESCRIPTION (continued)

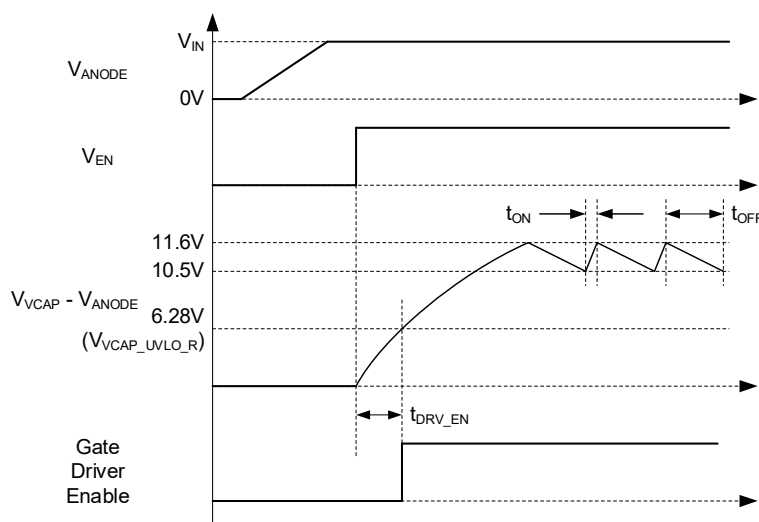


Figure 4. Charge Pump Operation

Gate Driver

The gate driver controls the external NMOS by adjusting the GATE to ANODE voltage to match the appropriate operating mode. Depending on the voltage difference between the ANODE pin and CATHODE pin, there are three distinct operational modes for the gate driver. These are forward regulation mode, full conduction mode, and reverse current protection. These three modes are described in more detail in the *Conduction Mode* section. Figure 5 illustrates the operating modes of the SGM25733Q as a function of the ANODE-to-CATHODE voltage. Transition from regulated conduction mode to full conduction mode occurs at 46mV, while the switch to reverse current protection mode happens when the ANODE-to-CATHODE voltage drops below -11mV.

In order to enable the gate driver, three specific requirements must all be satisfied:

- The voltage at the EN pin must exceed the Enable Input High Threshold.
- The VCAP-to-ANODE voltage must exceed the under-voltage lockout threshold.
- The ANODE voltage must exceed the VANODE POR rising threshold.

If these conditions are not met, the GATE pin is internally pulled to the ANODE pin. This ensures the external MOSFET is turned off. Once the conditions are satisfied, the gate driver functions according to the appropriate mode based on the ANODE-to-CATHODE voltage.

Enable

The SGM25733Q features an enable pin, EN. An external signal uses this pin to enable or disable the gate driver. When $V_{EN} > V_{EN_IH}$, the gate driver and charge pump function as outlined in the sections above. When $V_{EN} < V_{EN_IL}$, the charge pump and gate driver are disabled, causing the SGM25733Q to enter a shutdown state. The EN pin has a specified voltage tolerance ranging from -65V to 65V. When enable function is unnecessary, it can be directly connected to the ANODE pin. When EN pin floats, a 1.9μA internal sink current pulls it to a low level, thus disabling the device.

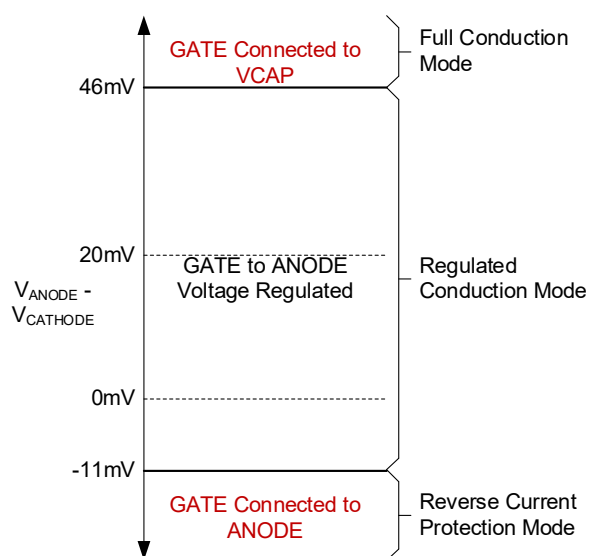


Figure 5. Gate Driver Mode Transitions

DETAILED DESCRIPTION (continued)**Device Functional Modes****Shutdown Mode**

When $V_{EN} < V_{EN_IL}$, the charge pump and gate driver are disabled, causing the SGM25733Q to enter the shutdown mode. During the shutdown mode, the SGM25733Q operates in a low-quiescent-current (low- I_Q) state. Specifically, the ANODE pin only consumes a current of 1.2 μ A. In shutdown mode, the SGM25733Q does not interrupt forward current flow through the external MOSFET. Instead, the current is conducted through the MOSFET's body diode.

Conduction Mode

When the gate driver is activated, the SGM25733Q enters the conduction mode. In this conduction mode, the device's operation can be divided into three distinct regions, which are determined by the voltage difference between the ANODE and the CATHODE. These three modes are detailed in the sections below.

Regulated Conduction Mode

To allow the SGM25733Q to function in regulated conduction mode, the gate driver should be activated as specified in the *Gate Driver* section. Additionally, the current passing from the source to the drain of the external MOSFET should be in the range that enables the ANODE pin to CATHODE pin voltage drop from -11mV to 46mV. In forward regulation mode, the ANODE-to-CATHODE voltage is controlled at 20mV by adjusting the GATE-to-ANODE voltage. This closed loop regulation mechanism allows the MOSFET to turn off smoothly under extremely light loads and guarantees that no DC reverse current occurs.

Full Conduction Mode

To allow the SGM25733Q to function in full conduction mode, the gate driver should be activated as specified in the *Gate Driver* section. Additionally, the current flowing from the source to the drain of the external MOSFET should be large enough that it causes the ANODE pin to CATHODE pin voltage drop greater than 46mV typical. Once these conditions are met, the GATE pin is internally connected to the VCAP pin. Consequently, the voltage between the GATE and the ANODE approximates that between the VCAP and the ANODE. Connecting the GATE pin to the VCAP pin leads to the minimization of the external MOSFET's $R_{DS(on)}$, thereby reducing power loss in the MOSFET during high forward current conditions.

Reverse Current Protection Mode

To allow the SGM25733Q to function in reverse current protection mode, the gate driver should be activated as specified in the *Gate Driver* section. Additionally, the current in the external MOSFET must flow from the drain to the source. When the ANODE-to-CATHODE voltage falls below approximately -11mV, reverse current protection mode is activated, and the GATE pin is internally connected to the ANODE pin. This connection disables the external MOSFET. The flow of reverse current from the drain to the source is interrupted by the body diode integrated within the MOSFET.

APPLICATION INFORMATION

In a typical reverse polarity protection use case, the SGM25733Q is used in conjunction with an NMOS. Figure 6 presents the schematic for the 12V battery protection application. In this setup, the MOSFET is driven by connecting the SGM25733Q and a battery in series.

The SGM25733Q can operate without TVS. However, the TVS devices are applied to limit both positive and negative voltage spikes. Meanwhile, it is advisable to utilize the output capacitor C_{OUT} . This capacitor helps prevent an abrupt drop in the output voltage caused by line disturbances.

Typical Application

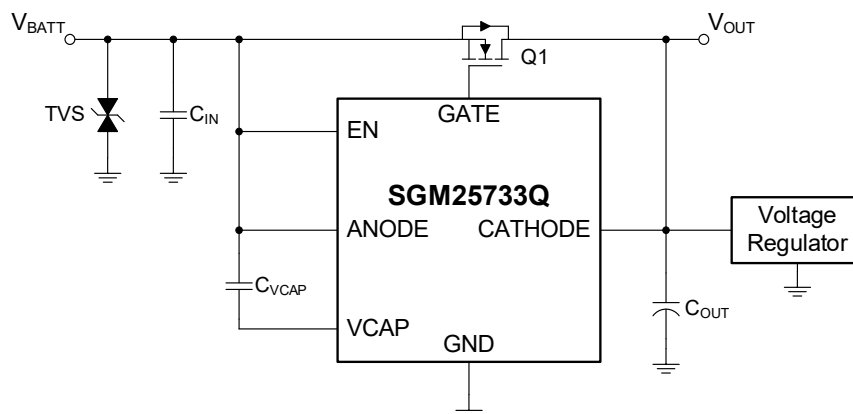


Figure 6. Typical Application Circuit

Design Requirements

A design sample is shown, where the system design parameters are detailed in Table 1.

Table 1. Design Parameters

| DESIGN PARAMETER | EXAMPLE VALUE |
|---------------------------|--|
| Input Voltage Range | 12V battery, 12V TYP with 3.2V cold crank and 35V load dump. |
| Output Voltage | 3.2V during cold crank to 35V load dump. |
| Output Current Range | 3A TYP, 5A MAX. |
| Output Capacitance | 1 μ F MIN, 47 μ F TYP hold up capacitance |
| Automotive EMC Compliance | ISO7637-2 and ISO16750-2 |

Detailed Design Procedure

Design Considerations

- Input operating voltage range, accounting for cold crank and load dump scenarios
- Typical load current and maximum load current requirements

MOSFET Selection

Key MOSFET electrical parameters include the maximum continuous drain current I_D , maximum drain-to-source voltage $V_{DS(MAX)}$, maximum source current through the body diode, and the drain-to-source on-resistance $R_{DS(on)}$.

The I_D rating should be higher than the maximum continuous load current, while the $V_{DS(MAX)}$ must be sufficient to handle the highest differential voltage encountered in the application, including any fault conditions that are expected. Considering the anode-cathode maximum voltage of the SGM25733Q is 65V, it's advisable to select MOSFETs with a voltage rating of up to 60V. The SGM25733Q can drive a V_{GS} up to a maximum of 13V. Thus, it is advisable to select a MOSFET with a minimum V_{GS} of 15V. If a MOSFET with a V_{GS} rating of less than 15V is selected, a Zener diode can be employed to clamp the V_{GS} to a safe level.

APPLICATION INFORMATION (continued)

To minimize the conduction losses of the MOSFET, it is preferable to choose a device with the lowest possible $R_{DS(on)}$. Nevertheless, choosing a MOSFET merely because of its low $R_{DS(on)}$ might not consistently lead to favorable results. A higher $R_{DS(on)}$ value offers enhanced voltage information to the reverse comparator of the SGM25733Q even at a relatively low reverse current. This means that reverse current detection becomes more effective when the $R_{DS(on)}$ is increased. Under nominal load conditions, it is suggested to operate the MOSFET in the regulated conduction mode. When selecting the MOSFET, the $R_{DS(on)}$ should be chosen in such a way that, at the nominal operating current, the forward voltage drop V_{DS} is close to the 20mV regulation point and does not exceed 46mV.

As a practical guideline, it is proposed that the selection of the MOSFET should follow the criterion where the $R_{DS(on)}$ satisfies the inequality $(20\text{mV} / I_{LOAD(TYP)}) \leq R_{DS(on)} \leq (46\text{mV} / I_{LOAD(TYP)})$. Typically, MOSFET manufacturers provide the specification of $R_{DS(on)}$ at V_{GS} values of 4.5V and 10V. The $R_{DS(on)}$ increases significantly when V_{GS} is below 4.5V, and it reaches its maximum value when V_{GS} is close to the MOSFET's threshold voltage V_{TH} . To ensure stable regulation under light load conditions, it is recommended to operate the MOSFET with a V_{GS} close to 4.5V, which is considerably higher than the MOSFET's gate threshold voltage. It is also suggested to choose a MOSFET with a maximum gate threshold voltage V_{TH} in the range of 2V to 2.5V. Selecting a MOSFET with a lower can also shorten the turn-on time.

According to the design requirements, the recommended MOSFET ratings are:

- 60V $V_{DS(MAX)}$ and $\pm 20\text{V } V_{GS(MAX)}$
- $R_{DS(on)}$ (at 3A TYP): $(20\text{mV} / 3\text{A} =) 6.67\text{m}\Omega$ to $(46\text{mV} / 3\text{A} =) 15.33\text{m}\Omega$
- MOSFET V_{TH} : 2V (MAX)

In order to meet the requirements of this 12V reverse battery protection design, the DMT6007LFG MOSFET from Diodes Inc. is chosen, and it is rated as:

- 60V $V_{DS(MAX)}$ and $\pm 20\text{V } V_{GS(MAX)}$
- $R_{DS(on)}$: 6.5m Ω (TYP) and 8.5m Ω (MAX) rated at 4.5V V_{GS}
- MOSFET V_{TH} : 2V (MAX)

To maintain safe operational conditions, the MOSFET's thermal resistance must be evaluated in relation to its anticipated maximum power dissipation, guaranteeing that the junction temperature (T_J) remains within prescribed limits.

Charge Pump $C_{V_{CAP}}$, Input and Output Capacitance

The minimum required capacitance values for the charge pump are as follows:

- $C_{V_{CAP}}$: A minimum of 0.1 μF is required, with a recommended value of $C_{V_{CAP}} (\mu\text{F}) \geq 10 \times C_{ISS_MOSFET} (\mu\text{F})$.
- C_{IN} : A minimum of 22nF for input capacitance.
- C_{OUT} : A minimum of 100nF for output capacitance.

SGM25733Q

Low Quiescent Current Ideal Diode Controller with Reverse Battery Protection

APPLICATION INFORMATION (continued)

Selection of TVS Diodes for 12V Battery Protection Applications

In automotive electrical systems, transient voltage suppression devices play a critical role in safeguarding circuits. For the 12V battery protection application circuit presented in Figure 7, a bi-directional TVS diode is used. It defends against transient voltage spikes in both the positive and negative polarities that happen when the car is running normally. The levels and pulses of these transient voltages are defined by the ISO7637-2 and ISO16750-2 standards.

Two key parameters of the TVS are its breakdown voltage and clamping voltage. The breakdown voltage is the voltage at which the TVS diode initiates an avalanche effect, similar to that of a Zener diode. It is specified under a low current condition, usually 1mA. The breakdown voltage must surpass the steady-state voltages encountered in the system under the worst case scenarios. The breakdown voltage of TVS+ is required to be greater than the 24V jump start voltage as well as the 35V suppressed load dump voltage, and it should be lower than the 65V maximum ratings of SGM25733Q. To safeguard against damage due to extended reverse-battery exposure, the breakdown voltage of TVS- should lower than the maximum reverse battery voltage of -16V.

The clamping voltage refers to the stabilized potential a TVS maintains during high-energy surge events, significantly exceeding its nominal breakdown threshold. TVS diodes are designed to suppress transient pulses without affecting the normal steady state operation of the circuit. Under the conditions of ISO7637-2 pulse 1, the input voltage can reach -150V, with the generator having an impedance of 10Ω. As a result, a current of 15A passes through the TVS-, and

the voltage across the TVS will be approximately equal to its clamping voltage.

An additional design constraint is to avoid exceeding the SGM25733Q's maximum reverse voltage limit from anode to cathode (-75V) as well as the MOSFET's V_{DS} rating. In the design example, a MOSFET rated for 60V is selected, and the maximum allowable cathode to anode voltage is set at 60V.

Under ISO7637-2 Pulse 1 conditions, the anode of the SGM25733Q is driven low by the transient pulse and clamped by the TVS diode. To stop the bulk output capacitors from being discharged by reverse current, the MOSFET is rapidly shut off. When the MOSFET turns off, the voltage across the cathode to anode becomes the sum of the TVS clamping voltage and the output capacitor voltage. Given that the output capacitor voltage can rise to 16V (the maximum battery voltage), the TVS clamping voltage must stay below $(60V - 16V) = 44V$ to remain within the system's voltage rating.

The SMBJ33CA TVS diode is suitable for 12V battery protection applications. Its breakdown voltage of 36.7V satisfies the requirements of jump start and load dump on the positive side, as well as for a 16V reverse battery connection on the negative side. During the ISO7637-2 Pulse 1 test, with a peak surge current of 15A, the SMBJ33CA exhibits a clamping voltage of -44V, as illustrated in Figure 7. This clamping voltage complies with the requirement of being $\leq 44V$.

The SMBJ series of TVS diodes have a rating of up to 600W peak pulse power levels. This power rating is adequate to handle the pulses specified in ISO7637-2 and the suppressed load dump pulses as per ISO16750-2 pulse B.

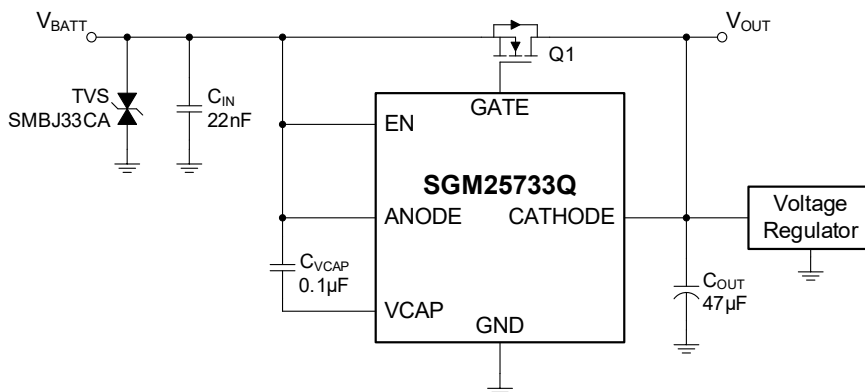


Figure 7. Single Bi-Directional TVS, 12V (TYP) Battery Protection

APPLICATION INFORMATION (continued)

**Selection of TVS Diodes and MOSFET for 24V
Battery Protection Applications**

In a standard 24V battery protection circuit, as depicted in Figure 8, two uni-directional TVS diodes are employed to safeguard against both positive and negative transient voltage spikes. For the TVS+ diode, its breakdown voltage must exceed the 48V jump start voltage. Simultaneously, it should not exceed the absolute maximum ratings of the anode and enable pin of the SGM25733Q, which is 65V. Additionally, it needs to endure the 65V suppressed load dump. Regarding the TVS diode, its breakdown voltage should be lower than the maximum reverse battery voltage of -32V. This ensures that the TVS- is not damaged during prolonged exposure to a reverse-connected battery.

During the ISO7637-2 Pulse 1 event, the input voltage reaches to -600V with a 50Ω generator impedance, causing 12A to flow through the TVS-. The clamping voltage of the TVS- in this scenario differs from that of the 12V battery protection setup. Since during the ISO7637-2 pulse, the ANODE-to-CATHODE voltage observed is equal to the sum of the negative TVS clamping voltage and

the output capacitor voltage. In a 24V battery application, where the maximum battery voltage amounts to 32V, the clamping voltage of the TVS- must not be more than 75V - 32V, equating to 43V.

A single bi-directional TVS diode is unsuitable for 24V battery protection due to the conflicting requirements for the breakdown voltage and clamping voltage. Specifically, the TVS+ requires a breakdown voltage of at least 65V, while the maximum clamping voltage must not exceed 43V, which is impossible since the clamping voltage cannot be lower than the breakdown voltage. Therefore, two uni-directional TVS diodes connected in a back-to-back configuration are necessary at the input. For the positive side TVS+, the SMBJ58A is suggested, featuring a minimum breakdown voltage of 64.4V and a typical value of 67.8V. For the negative side TVS-, the SMBJ26A is recommended, as it offers a breakdown voltage near 32V (to tolerate the maximum reverse battery voltage of -32V) and a maximum clamping voltage of 42.1V.

In the case of 24V battery protection, it is suggested to employ a MOSFET with a 75V rating. Additionally, at the input, the SMBJ26A and SMBJ58A, connected back-to-back, are to be utilized.

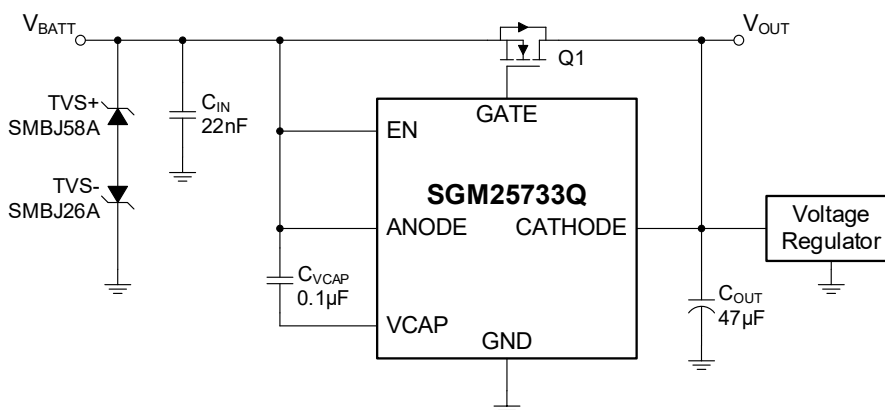


Figure 8. Two Uni-Directional TVS, 24V (TYP) Battery Protection

APPLICATION INFORMATION (continued)

ORing Application Configuration

A fundamental redundant power architecture consists of two or more voltage or power supply sources that power a single load. In its most elementary configuration, the ORing approach for redundant power supplies is constituted by Schottky ORing diodes. These diodes serve to defend the system from situations where the input power supply malfunctions. While diode ORing solution offers an efficient and cost-effective solution with minimal components, the forward voltage drop across the diodes leads to permanent efficiency losses. This is because each diode in an ORing setup primarily operates in forward conduction mode, resulting in continuous power dissipation. These power dissipations enhance the specifications for heat management and expand the required footprint on the printed circuit board.

As depicted in Figure 9, the SGM25733Q ICs, along with external NMOSs, can be utilized within an ORing Solution. During normal operation, the external NMOS turns on, minimizing the forward diode drop. The SGM25733Q is capable of quickly detecting reverse current. Upon detecting reverse current, it rapidly pulls down the gate of the MOSFET. This mechanism allows the body diode of the MOSFET to prevent the reverse current from passing through. To ensure an efficient ORing solution, rapid response is critical to minimize both the magnitude and duration of reverse current. In the ORing configuration, the SGM25733Q constantly monitors the voltage disparity between its ANODE and CATHODE pins. The ANODE pin represents the

voltage at the power sources (V_{IN1} , V_{IN2}), while the CATHODE pin represents the voltage at the shared load point. The SGM25733Q uses its ANODE and CATHODE pins to sense the source to drain voltage V_{DS} of each MOSFET. When the voltage difference $V_{IN} - V_{OUT}$ drops below -11mV, a high speed comparator quickly disables the gate drive by pulling it down within 0.44 μ s (TYP). Conversely, when the forward voltage differential $V_{IN} - V_{OUT}$ exceeds 46mV, the GATE is activated with an 11mA gate charge current.

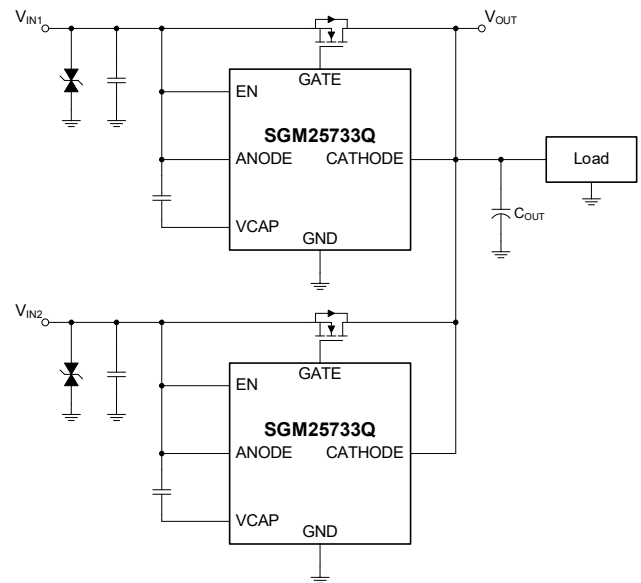
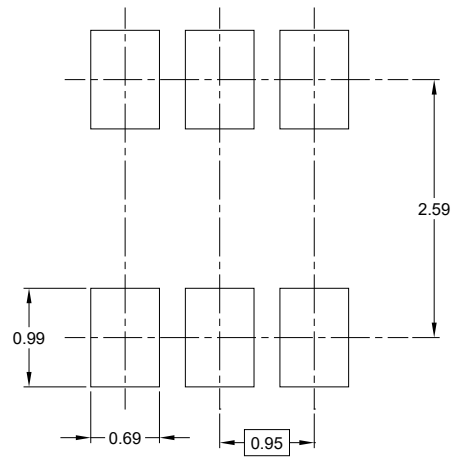
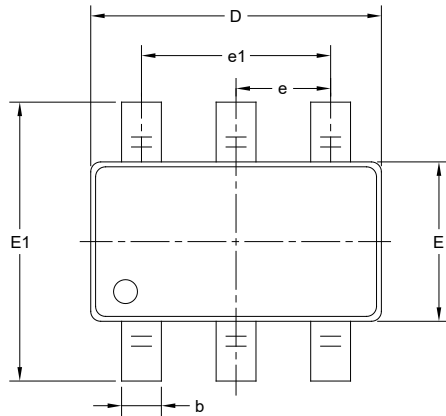


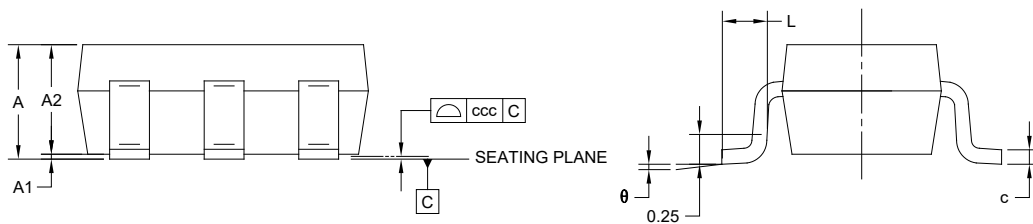
Figure 9. Typical ORing Application

PACKAGE OUTLINE DIMENSIONS

SOT-23-6



RECOMMENDED LAND PATTERN (Unit: mm)



| Symbol | Dimensions In Millimeters | | |
|----------|---------------------------|-----|-------|
| | MIN | NOM | MAX |
| A | - | - | 1.450 |
| A1 | 0.000 | - | 0.150 |
| A2 | 0.900 | - | 1.300 |
| b | 0.300 | - | 0.500 |
| c | 0.080 | - | 0.220 |
| D | 2.750 | - | 3.050 |
| E | 1.450 | - | 1.750 |
| E1 | 2.600 | - | 3.000 |
| e | 0.950 BSC | | |
| e1 | 1.900 BSC | | |
| L | 0.300 | - | 0.600 |
| θ | 0° | - | 8° |
| ccc | 0.100 | | |

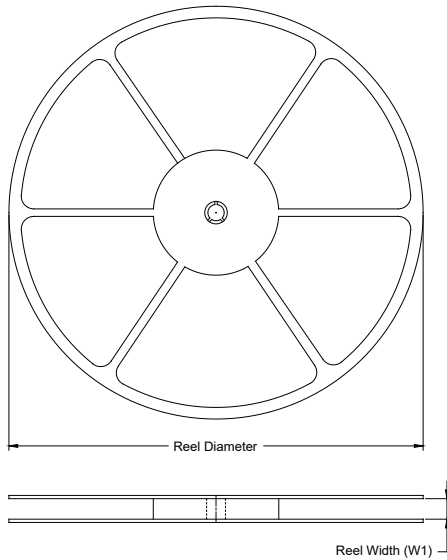
NOTES:

1. This drawing is subject to change without notice.
2. The dimensions do not include mold flashes, protrusions or gate burrs.
3. Reference JEDEC MO-178.

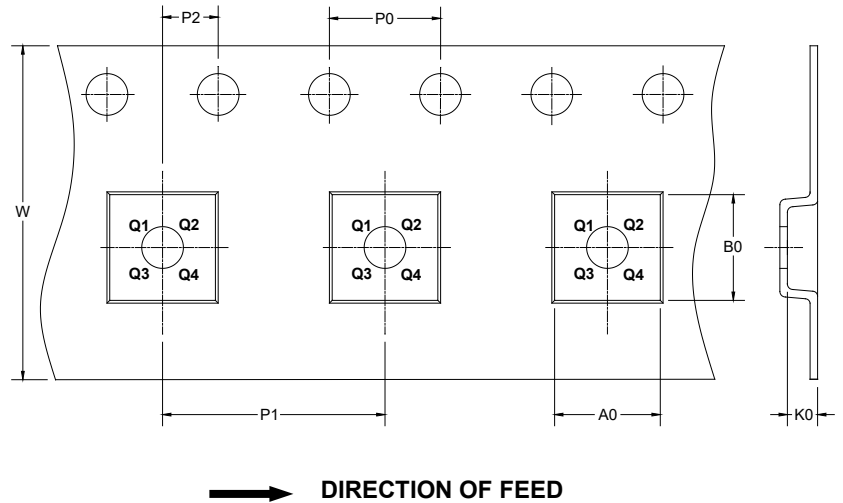
PACKAGE INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS



TAPE DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

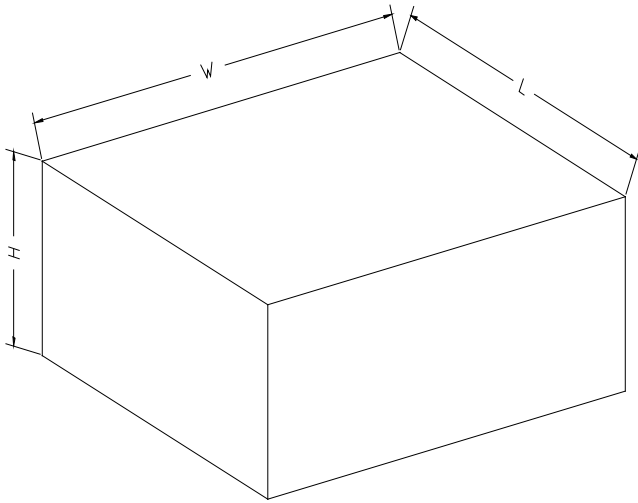
KEY PARAMETER LIST OF TAPE AND REEL

| Package Type | Reel Diameter | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P0 (mm) | P1 (mm) | P2 (mm) | W (mm) | Pin1 Quadrant |
|--------------|---------------|--------------------|---------|---------|---------|---------|---------|---------|--------|---------------|
| SOT-23-6 | 7" | 9.5 | 3.23 | 3.17 | 1.37 | 4.0 | 4.0 | 2.0 | 8.0 | Q3 |

DD0001

PACKAGE INFORMATION

CARTON BOX DIMENSIONS



NOTE: The picture is only for reference. Please make the object as the standard.

KEY PARAMETER LIST OF CARTON BOX

| Reel Type | Length (mm) | Width (mm) | Height (mm) | Pizza/Carton |
|-------------|-------------|------------|-------------|--------------|
| 7" (Option) | 368 | 227 | 224 | 8 |
| 7" | 442 | 410 | 224 | 18 |

DD0002